

Antenna **Specifications**

At Wavelink, our aim is to provide timely and comprehensive services to our customers. If you require any assistance, please contact our headquarters:

2nd Floor, Building D, No. 88 Tonggiu Road, ZhangPu Town, Kunshan City, Jiangsu Province, China Tel: +86-512-57449488

Email: sales@kswavelink.com

Wavelink Certifications:









Wavelink Partners:













Hikvision

Tel.:+86-512-57449488





Catalogue

1	Product Description	 .3
	Product Features	
	Product Specifications	
4	Overall Performance	. 4
5	Product Size	 . 7
6	Others	. 8



1 Product Description

This wavelink antenna covers 915MHz.

2 Product Features

Easy to install High efficiency Removable



3 Product Specifications

Passive Electrical Specifications		
Frequency Range	915MHz	
Input Impedance	50 Ω	



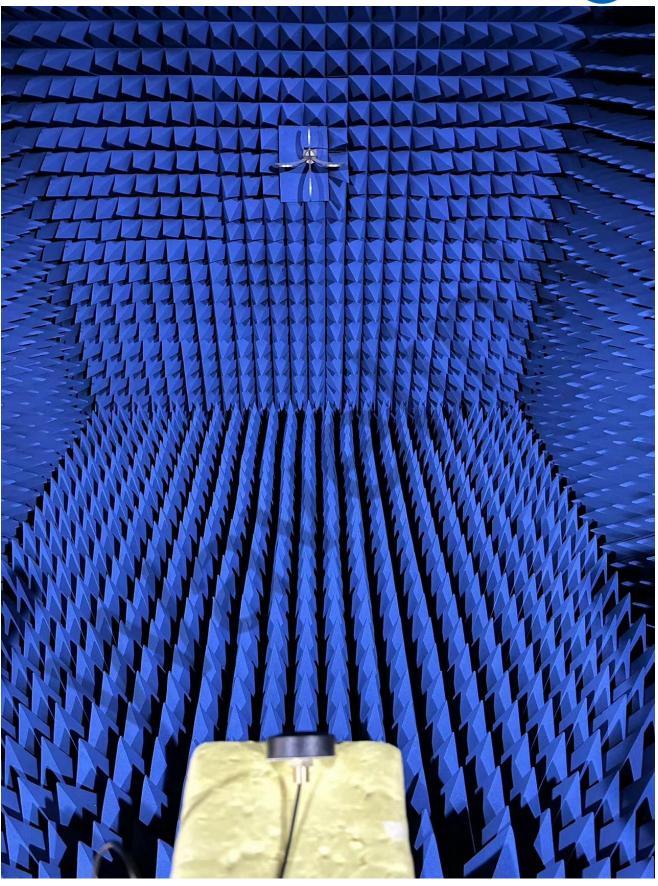
VSWR	<2.5
Gain	≤1 dBi
Polarization Type	Linear
Mechanical Specifications	
Antenna Size	46mm ×15mm
Antenna Size Connector Type	46mm ×15mm SMA
Connector Type	SMA

4 Overall Performance

KEYSIGHT VNA Network Analyzer E5071C 100 kHz - 8.5 GHz







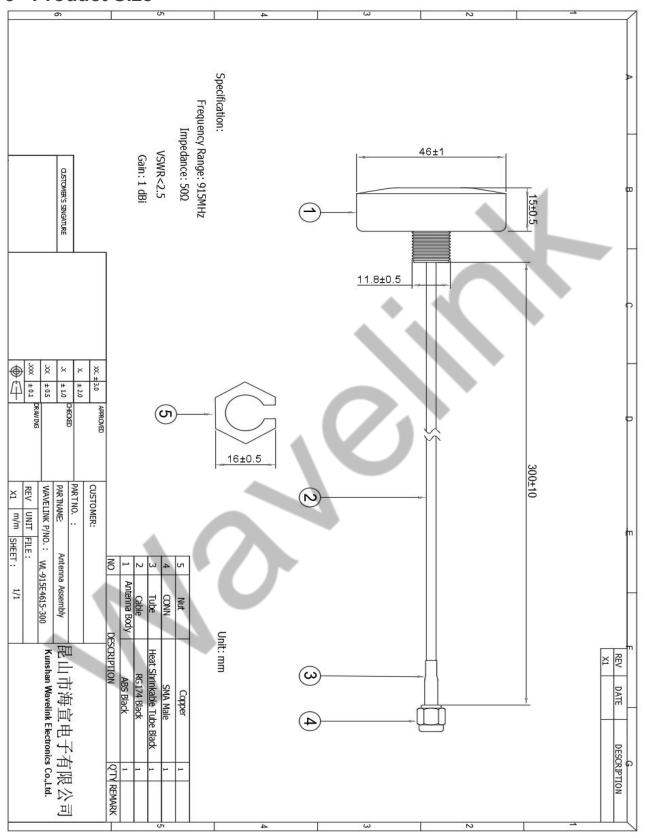


	Passive Test For 915									
Freq	Effi	Effi	Gain	Gain	Max	Min	Directivity	Beamwidth	AttH	AttV
(MHz)	(%)	(dB)	(dBi)	(dBd)	(dB)	(dB)	(dBi)	(3dB)	(dB)	(dB)
900	53. 9	-2.68	0.21	-1.94	0.21	-13.41	2.9	90	39. 79	39.68
905	54. 97	-2.6	0.3	-1.85	0.3	-13.82	2.9	90	40	39.87
910	55. 42	-2 . 56	0.35	-1.8	0.35	-14.48	2.91	90	40.06	39. 95
915	55. 12	-2.59	0.38	-1.77	0.38	-14.69	2. 96	90	40. 13	40.03
920	54. 16	-2 . 66	0.36	-1.79	0.36	-14.7	3.02	90	40. 18	40.08

Frequency	3D	E1	E2	Н
915MHz	915.000WH2 0.4 0.5 2.1 3.6 5.6 7.6 9.5	915.000MHz E1 5.00 310 5.00 330 5.00 330 5.00 770 720 720 7210	915.000MHz E2 5.00 10.00 12	915.000MHz H 30 5.00 15.00



5 Product Size





6 Others

DESCRIPTION	SPECIFICATION
Temperature /Humidity cycling	 The device under test is kept for 30 mins in an environment with a temperature of -40 °C. Kept for 4 Hours in an environment with a temperature of 8cthe conditions are stabilized at room temperature. Parts should meet RF spec before and after test. No cosmetic problem(No soldering problem; No adhesion problem of glue).
Temperature Shock	 The device under test at -40 °C ⇔125 °C by 100 cycles, Dwell of 30 mins, transition time between Dwell 30 secs (~ 61 mins / cycle) and each item should be measured after exposing them in normal temperature and humidity for 24 h. Parts should meet RF spec before and after test. No cosmetic problem(No soldering problem; No adhesion problem of glue).
High Temperature	 Temperature:125 ℃, time:1008 hours There is no substantial obstruction to air flow across and around the samples, and the samples are not touching each other Parts should meet RF spec before and after test. No cosmetic problem(No soldering problem; No adhesion problem of glue).
Salt mist test	1, The device under test is exposed to a spray of a 5% (by volume) resolution of NACL in water for 2 hours. Thereafter the device under test is left for 1 week in room temperature at a relative humidity of 95%. The cycle is repeated until a total of 2 cycles have been completed. Here after the conditions are stabilized at room temperature. 2, Parts should meet RF spec before and after test. 3, No visible corrosion. Discoloration accept.